

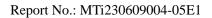
Test Report

Report No.:	MTi230609004-05E1			
Date of issue:	2023-07-14			
Applicant:	Zhuhai Quin Technology Co., Ltd.			
Product:	Portable Printer			
Model(s):	M832, M832W, M832S, M832Pro, M832HD, M832XL, M832Plus, M832Max, M832SE, M832C, M8A32, M8A32W, M8A32S, M8A32Pro, M8A32HD, M8A32XL, M8A32Plus, M8A32Max, M8A32SE, M8A32C, M822, M822W, M822S, M822Pro, M822HD, M822XL, M822Plus, M822Max, M822SE, M822C, M8A22, M8A22W, M8A22S, M8A22Pro, M8A22HD, M8A22XL, M8A22Plus, M8A22Max, M8A22SE, M8A22C			
FCC ID	2ASRB-M832			

Shenzhen Microtest Co., Ltd. http://www.mtitest.com

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- 5. Any objection to this test report shall be submitted to the laboratory within 15 days from the date of receipt of the report.



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Test Result Certification				
Applicant:	Zhuhai Quin Technology Co., Ltd.			
Address:	ROOM 103-029(CENTRALIZED OFFICE AREA) , 1F, BUILDING 1, NO. 18 FUTIAN ROAD, XIANGZHOU DISTRICT, ZHUHAI CITY, CHINA			
Manufacturer:	Zhuhai Quin Technology Co., Ltd.			
Address:	ROOM 103-029(CENTRALIZED OFFICE AREA) , 1F, BUILDING 1, NO. 18 FUTIAN ROAD, XIANGZHOU DISTRICT, ZHUHAI CITY, CHINA			
Product description				
Product name:	Portable Printer			
Trade mark:	N/A			
Model name:	M832			
Series Model:	Pries Model: M832W, M832S, M832Pro, M832HD, M832XL, M832Plus, M832Max, M832SE, M832C, M8A32, M8A32W, M8A32S, M8A32Pro, M8A32HD, M8A32XL, M8A32Plus, M8A32Max, M8A32SE, M8A32C, M822, M822W M822S, M822Pro, M822HD, M822XL, M822Plus, M822Max, M822SE, M822C, M8A22, M8A22W, M8A22S, M8A22Pro, M8A22HD, M8A22XL, M8A22Plus, M8A22Max, M8A22SE, M8A22C			
Standards:	FCC 47 CFR Part 15 Subpart C			
Test method:	nethod: ANSI C63.10-2013 KDB 558074 D01 15.247 Meas Guidance v05r02			
Date of Test	Date of Test			
Date of test:	2023-07-07 to 2023-07-10			
Test result:	Pass			

Test Engineer	:	Letter. Jan.
		(Letter Lan)
Reviewed By	:	leon chen
		(Leon Chen)
Approved By	:	Tom Xue
		(Tom Xue)



1 General Description

1.1 Description of the EUT

Product name:	Portable Printer		
Model name:	M832		
Series Model:	M832W, M832S, M832Pro, M832HD, M832XL, M832Plus, M832Max, M832SE, M832C, M8A32, M8A32W, M8A32S, M8A32Pro, M8A32HD, M8A32XL, M8A32Plus, M8A32Max, M8A32SE, M8A32C, M822, M822W, M822S, M822Pro, M822HD, M822XL, M822Plus, M822Max, M822SE, M822C, M8A22, M8A22W, M8A22S, M8A22Pro, M8A22HD, M8A22XL, M8A22Plus, M8A22Max, M8A22SE, M8A22C		
Model difference:	All the models are the same circuit and module, except the model name, colour and silk-screen.		
Electrical rating:	Input: DC 5V/2A Battery: 7.4V 2600mAh		
Accessories:	Cable: USB-A to USB-C cable 0.8m		
Hardware version:	Q252_A		
Software version:	0.1.0		
Test sample(s) number: MTi230609004-05S1001			
RF specification			
Bluetooth version:	V5.1		
Operating frequency range:	2402MHz to 2480MHz		
Channel number:	79		
Modulation type:	GFSK, π/4 DQPSK		
Antenna(s) type:	PCB Antenna		
Antenna(s) gain:	-0.58 dBi		

1.2 Description of test modes

No.	Emission test modes
Mode1	TX-GFSK
Mode2	TX-Pi/4DQPSK

1.2.1 Operation channel list

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468



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7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461	-	-

Note: The test software provided by manufacturer is used to control EUT for working in engineering mode, that enables selectable channel, and capable of continuous transmitting mode.

Test Software:

For power setting, refer to below table.

Mode	Test Software		FCC Assist 1.0.2.2	
Mode	Channel	2402MHz	2441MHz	2480MHz
GFSK	Dower opting	10	10	10
π/4-DQPSK	Power setting	10	10	10



1.3 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C ~ 35°C
Humidity:	20% RH ~ 75% RH
Atmospheric pressure:	98 kPa ~ 101 kPa

1.4 Description of support units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Support equipment list						
Description	Model	Serial No.	Manufacturer			
MI CHARGE(18W) MDY-08-EH YJ2808215006999 MI						
Support cable list						
Description	Length (m)	From	То			
/	1	/	/			

1.5 Measurement uncertainty

Measurement	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	3.1dB
Occupied channel bandwidth	±3 %
RF output power, conducted	±1 dB
Time	±1 %
Unwanted Emissions, conducted	±1 dB
Radiated spurious emissions (1GHz~25GHz)	5.3dB
Radiated spurious emissions (9kHz~30MHz)	4.3dB
Radiated spurious emissions (30MHz~1GHz)	4.7dB
Temperature	±1 °C
Humidity	± 5 %

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



2 Summary of Test Result

No.	FCC reference	Description of test	Result
1	§ 15.203	Antenna requirement	Pass
2	§ 15.207	AC power line conducted emissions	Pass
3	§ 15.247(d), 15.209, 15.205	Radiated spurious emissions	Pass
4	§ 15.247(a)(1)	20dB emission bandwidth	Pass
5	§ 15.247(b)(1)	Maximum conducted output power	Pass
6	§ 15.247(a)(1)	Carrier Frequencies Separation	Pass
7	§ 15.247(a)(1)	Time of occupancy	Pass
8	§ 15.247(a)(1)	Number of hopping channels	Pass
9	§ 15.247(d)	Band edge (Conducted)	Pass
10	§ 15.247(d)	Conducted spurious emissions	Pass



3 Test Facilities and accreditations

3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.					
Test site location:	101, No.7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China					
Telephone:	(86-755)88850135					
Fax:	(86-755)88850136					
CNAS Registration No.:	CNAS L5868					
FCC Registration No.:	448573					



4 List of test equipment

No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due		
Conducted Emission at AC power line								
1	EMI Test Receiver	Rohde&schwarz	ESCI3 101368		2023-04-26	2024-04-25		
2	Artificial mains network	Schwarzbeck	NSLK 8127	183	2023-05-05	2024-05-04		
3	Artificial Mains Network	Schwarzbeck	NSLK 8127	1001	2023-05-06	2024-05-05		
		Occuj	pied Bandwidth					
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
		Maximum Co	nducted Output	Power	I			
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
	Channel Separation							
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		



No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
		Number of I	Hopping Freque	ncies				
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
		Γ	Dwell Time					
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25		
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25		
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04		
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24		
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04		
	Emissions in non-restricted frequency bands							
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25		
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24		
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24		
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24		



No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04
		Band edge	emissions (Radi	ated)		
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-05-26	2024-05-25
3	Amplifier	Agilent	8449B	3008A01120	2023-05-26	2024-05-25
4	Multi-device Controller	TuoPu	TPMDC	/	/	/
5	MXA signal analyzer	Agilent	N9020A	MY54440859	2023-05-05	2024-05-04
	Em	issions in restricted	I frequency band	ls (below 1GHz)		
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25
2	TRILOG Broadband Antenna	schwarabeck	VULB 9163	9163-1338	2023-06-11	2025-06-10
3	Amplifier	Hewlett-Packard	8447F	3113A06184	2023-04-26	2024-04-25
4	Multi-device Controller	TuoPu	TPMDC	/	/	/
	Em	issions in restricted	frequency band	s (above 1GHz)		
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-05-26	2024-05-25
3	Amplifier	Agilent	8449B	3008A01120	2023-05-26	2024-05-25
4	Multi-device Controller	TuoPu	TPMDC	1	/	/
5	MXA signal analyzer	Agilent	N9020A	MY54440859	2023-05-05	2024-05-04



5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Test Requirement:	An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.
Description of the antenna of EUT:	The antenna of the EUT is permanently attached.
Conclusion:	The EUT complies with the requirement of FCC PART 15.203.

6 Radio Spectrum Matter Test Results (RF)

6.1 Conducted Emission at AC power line

Test Requirement:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	Occupied bandwidth—relative measurement procedure
Procedure:	 a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2. d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value). h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.



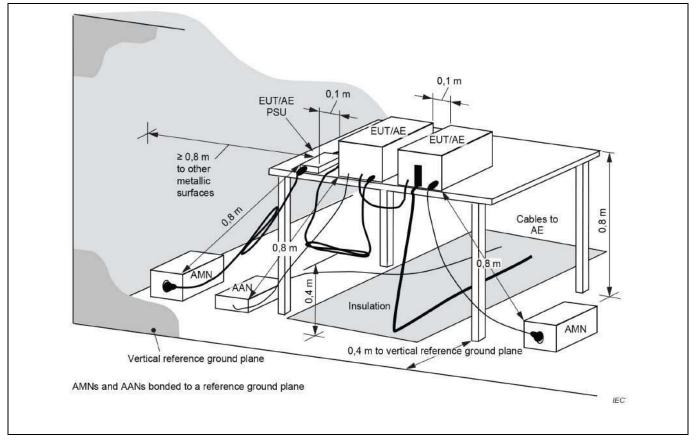
	 i) If the reference value is determ the EUT modulation ON, and eith trace on the spectrum analyzer a Otherwise, the trace from step gy j) Place two markers, one at the frequency of the envelope of the or slightly below the "-xx dB dow marker is below this "-xx dB dow as possible to this value. The occ between the two markers. Alterna of the envelope of the spectral di below the "-xx dB down amplitud delta function and move the mark delta marker amplitude is at the s amplitude. The marker-delta freq emission bandwidth. k) The occupied bandwidth shall measuring instrument display; th shall be clearly labeled. Tabular o plot(s). 	her clear the existing train and allow the new trace is shall be used for step j lowest frequency and the spectral display, such the n amplitude" determined in amplitude" value, the cupied bandwidth is the atively, set a marker at t splay, such that the mar e" determined in step h) ker to the other side of the same level as the reference uency reading at this por- be reported by providing e plot axes and the scal	ce or start a new to stabilize.). e other at the high hat each marker d in step h). If a n it shall be as c frequency different he lowest frequent ker is at or sligh b. Reset the mark he emission untion nce marker bint is the specifier g plot(s) of the e units per divisi	y ghest is at lose ence ency tly ker- I the ed			
Test Limit:	Frequency of emission (MHz)	Conducted limit (dBµV	/)				
		Quasi-peak	Average				
	0.15-0.5	66 to 56*	56 to 46*				
	0.5-5 56 46						
	5-30 60 50						
	*Decreases with the logarithm of the frequency.						
Test Method:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power- line conducted emissions from unlicensed wireless devices						

6.1.1 E.U.T. Operation:

Operating Environment:								
Temperature: 25.6 °C Humidity: 62 % Atmospheric Pressure: 101 kPa						101 kPa		
Pre test mode:	Pre test mode: Mode1, Mode2							
Final test mode: All of the listed pre-test mode were tested, only the data (Mode1) is recorded in the report						of the worst mode		

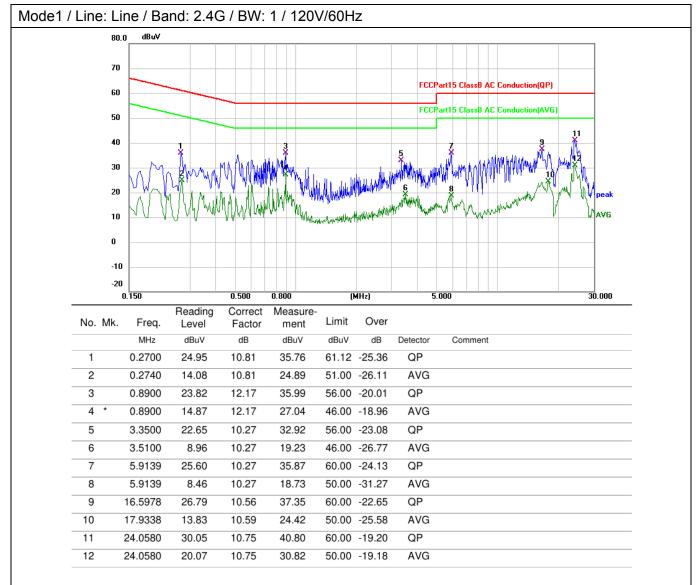


6.1.2 Test Setup Diagram:

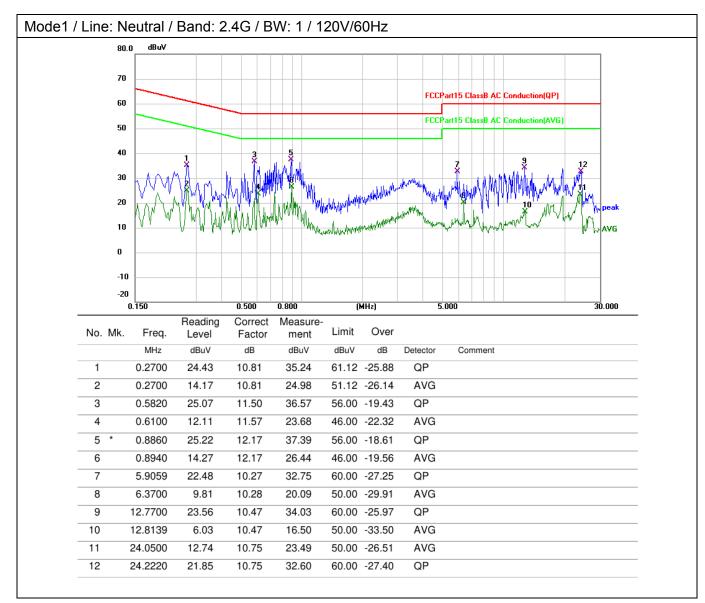




6.1.3 Test Data:









6.2 Occupied Bandwidth

-	
Test Requirement:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Limit:	Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	Occupied bandwidth—relative measurement procedure
Procedure:	 a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2. d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value. f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value). h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument. i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j). j) Place two markers, one at the lowest frequency and the other at the highest frequency of the enve
<u> </u>	



emission bandwidth. k) The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

6.2.1 E.U.T. Operation:

Operating Environment:								
Temperature:	Temperature:25 °CHumidity:50 %Atmospheric Pressure:100 kPa							
Pre test mode:	Pre test mode: Mode1, Mode2							
Final test mode: Mod			e1, Mode2					

6.2.2 Test Data:



6.3 Maximum Conducted Output Power

Test Requirement: Test Limit:	 For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts. For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency
Test Limit:	employing at least 75 non-overlapping hopping channels, and all frequency
	hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	Output power test procedure for frequency-hopping spread-spectrum (FHSS) devices
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

6.3.1 E.U.T. Operation:

Operating Environment:							
Temperature:	25 °C Humidity: 50 % Atmospheric Pressure: 100 kPa						
Pre test mode: Mo			e1, Mode2				
Final test mode: Mode1, Mode2							

6.3.2 Test Data:



6.4 Channel Separation

Test Requirement:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Limit:	Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	Carrier frequency separation
Procedure:	 The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks
	of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

6.4.1 E.U.T. Operation:

Operating Environment:							
Temperature:	25 °C		Humidity:	50 %	Atmospheric Pressure:	100 kPa	
Pre test mode: Mod			e1, Mode2				
Final test mode: Mod			e1, Mode2				

6.4.2 Test Data:



6.5 Number of Hopping Frequencies

Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Number of hopping frequencies
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.

6.5.1 E.U.T. Operation:

Operating Environment:							
Temperature:	Temperature: 25 °C Humidity: 50 % Atmospheric Pressure: 100 kPa						
Pre test mode: Mode1, Mode2							
Final test mode: Mode1, Mode2							

6.5.2 Test Data:



6.6 Dwell Time

Test Requirement:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Limit:	Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	Time of occupancy (dwell time)
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation: (Number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the values described in the operational description for the EUT.

6.6.1 E.U.T. Operation:

Operating Environment:							
Temperature:	25 °C	25 °C Humidity: 50 % Atmospheric Pressure: 100 kPa					
Pre test mode: M			e1, Mode2				
Final test mode: Mo		Mode	e1, Mode2				

6.6.2 Test Data:



6.7 Emissions in non-restricted frequency bands

Test Requirement:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	Conducted spurious emissions test methodology
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.

6.7.1 E.U.T. Operation:

Operating Environment:

operating Environment.							
Temperature:	25 °C		Humidity:	50 %	Atmospheric Pressure:	100 kPa	
Pre test mode: Mod			e1, Mode2				
Final test mode: Mod			e1, Mode2				

6.7.2 Test Data:



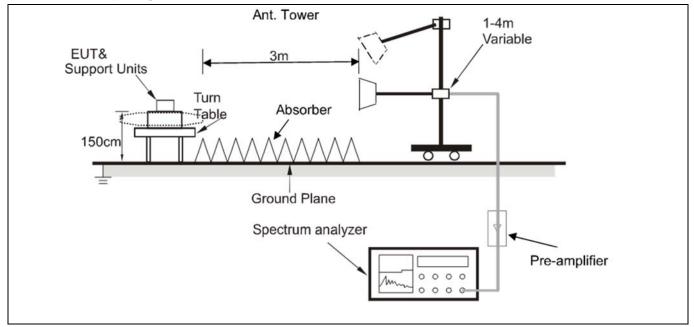
6.8 Band edge emissions (Radiated)

Test Requirement:	In addition, radiated emissions which fall in the restricted bands, as defined in § $15.205(a)$, must also comply with the radiated emission limits specified in § $15.209(a)(see \ 15.205(c))$.						
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
	Above 960 500 3						
	 ** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. 						
Test Method:	Radiated emissions tests						
Procedure:	ANSI C63.10-2013 sec	ction 6.10.5.2					

6.8.1 E.U.T. Operation:

Operating Environment:							
Temperature:	Temperature: 25 °C Humidity: 59 % Atmospheric Pressure: 101 kPa						
Pre test mode:	Pre test mode: Mode1, Mode2						
Final test mode: All of the listed pre-test mode were tested, only the data of the worst mode (Mode2) is recorded in the report							
1			ez) is recor	aea in ine repo	I Contraction of Cont		

6.8.2 Test Setup Diagram:





6.8.3 Test Data:

Mode2 /	Polari	zatio	on: Horizonta	al / Band: 2.	4G / BW: 1	.2 / CH: 240	2			
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
-			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	_
	1		2310.000	47.90	-8.08	39.82	74.00	-34.18	peak	-
-	2		2310.000	37.40	-8.08	29.32	54.00	-24.68	AVG	-
-	3		2390.000	57.03	-7.71	49.32	74.00	-24.68	peak	-
	4	*	2390.000	45.68	-7.71	37.97	54.00	-16.03	AVG	_

No	. M	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		2310.000	47.82	-8.08	39.74	74.00	-34.26	peak
2		2310.000	37.48	-8.08	29.40	54.00	-24.60	AVG
3		2390.000	51.31	-7.71	43.60	74.00	-30.40	peak
4	*	2390.000	41.67	-7.71	33.96	54.00	-20.04	AVG



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lode2 /	Polari	zatio	on: Horizont	al / Band: 2.	4G / BW: 1	.2 / CH: 248	0		
	No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
-			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
-	1		2483.500	49.17	-7.24	41.93	74.00	-32.07	peak
-	2		2483.500	38.88	-7.24	31.64	54.00	-22.36	AVG
	3		2500.000	50.98	-7.17	43.81	74.00	-30.19	peak
-	4	*	2500.000	41.31	-7.17	34.14	54.00	-19.86	AVG

No.	Mł	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		2483.500	58.44	-7.24	51.20	74.00	-22.80	peak
2		2483.500	41.52	-7.24	34.28	54.00	-19.72	AVG
3		2500.000	55.61	-7.17	48.44	74.00	-25.56	peak
4	*	2500.000	45.80	-7.17	38.63	54.00	-15.37	AVG



6.9 Emissions in restricted frequency bands (below 1GHz)

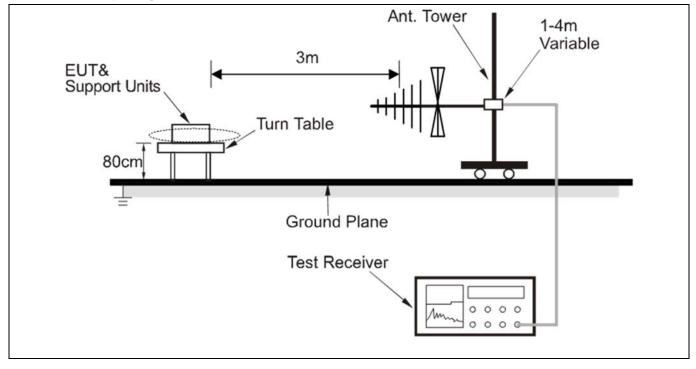
Test Requirement:		nissions which fall in the rest comply with the radiated em 5(c)).`	
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72	•	all not be located in the MHz or 470-806 MHz.
Test Method:	Radiated emissions tes	sts	
Procedure:	ANSI C63.10-2013 sec	ction 6.6.4	

6.9.1 E.U.T. Operation:

Operating Env	ironment:					
Temperature:	25 °C		Humidity:	58 %	Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2			
Final test mode	ə:	Note				
				f spurious emis are not reported	sions which are attenuate d.	d more than 20 dB
			odes of ope ts are repor		JT were investigated, and	only the worst-case
		Ther	e were no e	missions found	below 30MHz within 20d	B of the limit.

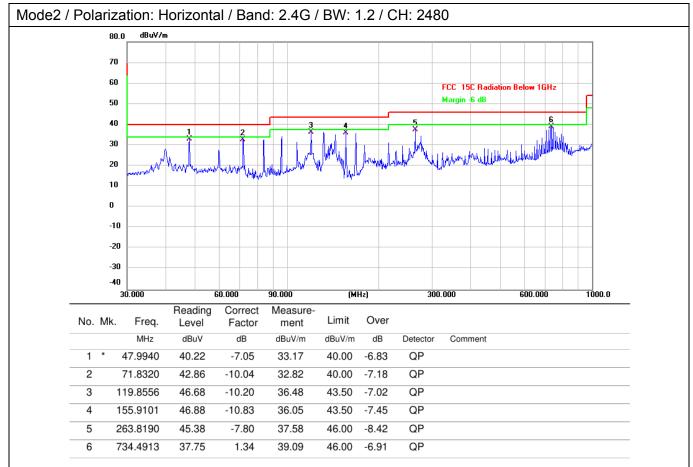


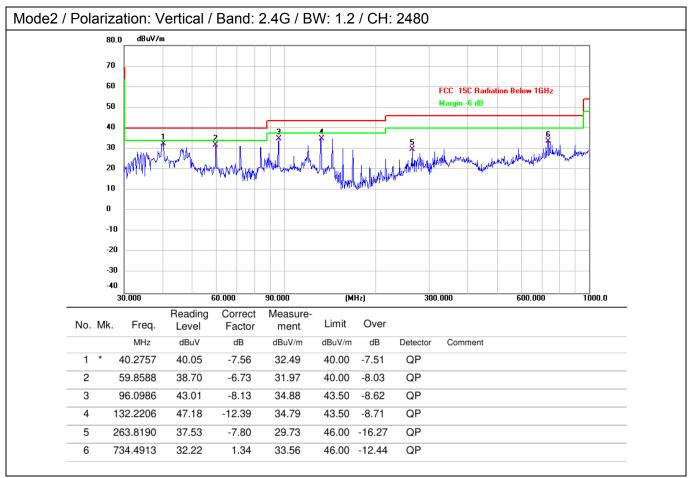
6.9.2 Test Setup Diagram:





6.9.3 Test Data:





Address: 101, No. 7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, ChinaTel: (86-755)88850135Fax: (86-755) 88850136Web: www.mtitest.comE-mail: mti@51mti.com

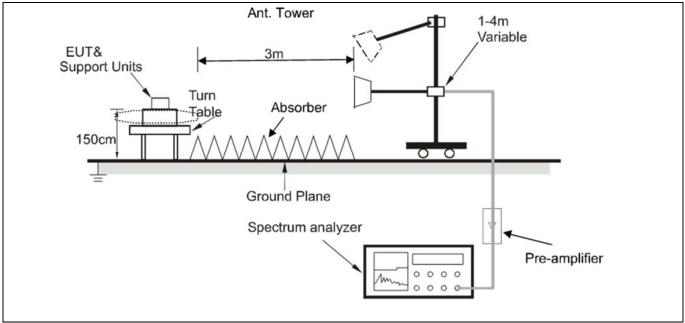
6.10 Emissions in restricted frequency bands (above 1GHz)

Test Requirement:	-	nissions which fall in the rest comply with the radiated em 5(c)).`	-
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72	-	nall not be located in the MHz or 470-806 MHz.
Test Method:	Radiated emissions tes	sts	
Procedure:	ANSI C63.10-2013 sec	tion 6.6.4	

6.10.1 E.U.T. Operation:

Operating Envi	ronment:					
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	101 kPa
Pre test mode:		Mode	e1, Mode2			
Final test mode):			re-test mode w ded in the repo	ere tested, only the data or rt	of the worst mode

6.10.2 Test Setup Diagram:



Note: All other emissions are attenuated 20dB below the limit, so does not recorded.



6.10.3 Test Data:

Mode2 /	Polariza	ation:	Horizonta	al / Band: 2.	4G / BW: 1	.2 / CH: 240	2			-
	No. N	Иk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	
	1	48	04.000	42.96	0.74	43.70	74.00	-30.30	peak	
	2	48	04.000	36.55	0.74	37.29	54.00	-16.71	AVG	
	3	72	06.000	40.61	6.02	46.63	74.00	-27.37	peak	
	4	72	06.000	34.30	6.02	40.32	54.00	-13.68	AVG	
	5	96	08.000	46.97	5.88	52.85	74.00	-21.15	peak	
	6	* 96	08.000	40.50	5.88	46.38	54.00	-7.62	AVG	
										· · · · ·

No	. Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4804.000	41.21	0.74	41.95	74.00	-32.05	peak
2		4804.000	34.71	0.74	35.45	54.00	-18.55	AVG
3		7206.000	40.76	6.02	46.78	74.00	-27.22	peak
4		7206.000	34.31	6.02	40.33	54.00	-13.67	AVG
5		9608.000	41.26	5.88	47.14	74.00	-26.86	peak
6	*	9608.000	35.24	5.88	41.12	54.00	-12.88	AVG



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No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4882.000	44.53	1.05	45.58	74.00	-28.42	peak
2		4882.000	38.17	1.05	39.22	54.00	-14.78	AVG
3		7323.000	41.19	5.94	47.13	74.00	-26.87	peak
4		7323.000	35.16	5.94	41.10	54.00	-12.90	AVG
5		9764.000	44.99	6.55	51.54	74.00	-22.46	peak
6	*	9764.000	38.68	6.55	45.23	54.00	-8.77	AVG

No	M	۲.	Freq.	Reading Level	Corre Facto		e- Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		488	2.000	40.63	1.05	5 41.68	74.00	-32.32	peak
2		488	2.000	34.23	1.05	5 35.28	54.00	-18.72	AVG
3		732	3.000	42.67	5.94	48.61	74.00	-25.39	peak
4		732	3.000	36.23	5.94	42.17	54.00	-11.83	AVG
5		976	4.000	43.28	6.55	5 49.83	74.00	-24.17	peak
6	*	976	4.000	36.81	6.55	5 43.36	54.00	-10.64	AVG



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No.	Mk.	Freq.	al / Band: 2. Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4960.000	47.10	1.50	48.60	74.00	-25.40	peak
2		4960.000	40.85	1.50	42.35	54.00	-11.65	AVG
3		7440.000	40.91	5.61	46.52	74.00	-27.48	peak
4		7440.000	34.58	5.61	40.19	54.00	-13.81	AVG
5		9920.000	45.61	6.10	51.71	74.00	-22.29	peak
6	*	9920.000	39.29	6.10	45.39	54.00	-8.61	AVG

No	. Mł	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4960.000	41.65	1.50	43.15	74.00	-30.85	peak
2		4960.000	35.62	1.50	37.12	54.00	-16.88	AVG
3		7440.000	40.11	5.61	45.72	74.00	-28.28	peak
4		7440.000	33.67	5.61	39.28	54.00	-14.72	AVG
5		9920.000	42.42	6.10	48.52	74.00	-25.48	peak
6	*	9920.000	36.21	6.10	42.31	54.00	-11.69	AVG



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Photographs of the EUT



Appendix

Appendix A: 20dB Emission Bandwidth

Test Result

Test Mode	Antenna	Frequency [MHz]	20db EBW [MHz]
		2402	1.026
DH5	Ant1	2441	1.044
		2480	1.044
		2402	1.278
2DH5	Ant1	2441	1.302
		2480	1.332









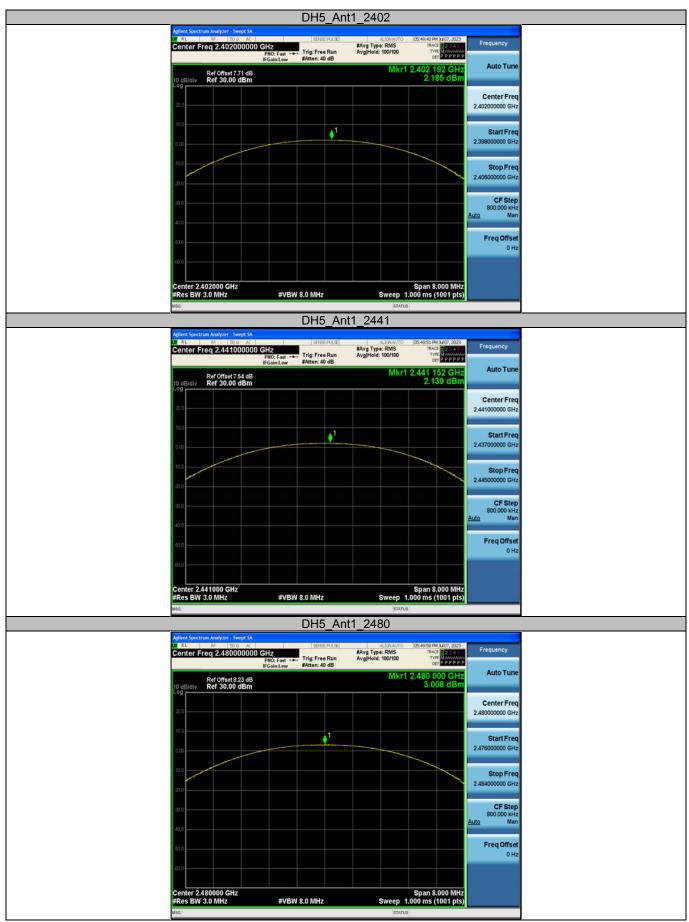


Appendix B: Maximum conducted output power

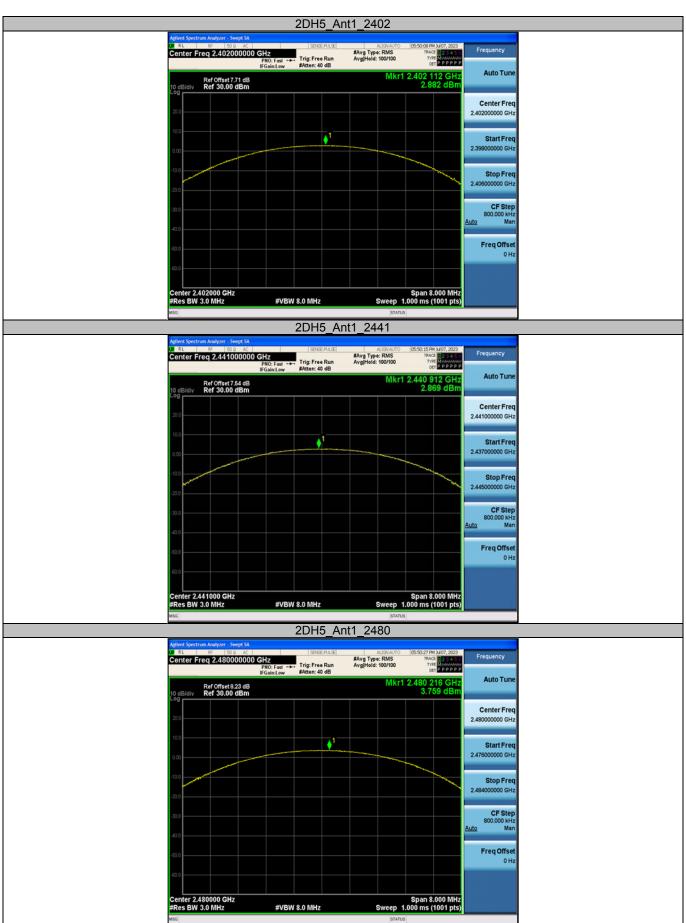
Test Result Peak

Test Mode	Antenna	Frequency [MHz]	Conducted Peak Power [dBm]	Limit [dBm]	Verdict
		2402	2.19	≤20.97	PASS
DH5	Ant1	2441	2.14	≤20.97	PASS
		2480	3.01	≤20.97	PASS
2DH5		2402	2.88	≤20.97	PASS
		2441	2.87	≤20.97	PASS
		2480	3.76	≤20.97	PASS











Appendix C: Carrier frequency separation

Test Result

Test Mode	Antenna	Frequency [MHz]	Result [MHz]	Limit [MHz]	Verdict
DH5	Ant1	Нор	1	≥0.696	PASS
2DH5	Ant1	Нор	0.996	≥0.888	PASS







Appendix D: Time of occupancy

Test Result

Test Mode	Antenna	Frequency [MHz]	BurstWidth [ms]	Hops in 31.6s [Num]	Result [s]	Limit [s]	Verdict
DH1	Ant1	Нор	0.375	319	0.12	≤0.4	PASS
DH3	Ant1	Нор	1.631	164	0.267	≤0.4	PASS
DH5	Ant1	Нор	2.878	108	0.311	≤0.4	PASS
2DH1	Ant1	Нор	0.385	319	0.123	≤0.4	PASS
2DH3	Ant1	Нор	1.637	159	0.26	≤0.4	PASS
2DH5	Ant1	Нор	2.884	123	0.355	≤0.4	PASS

Notes:

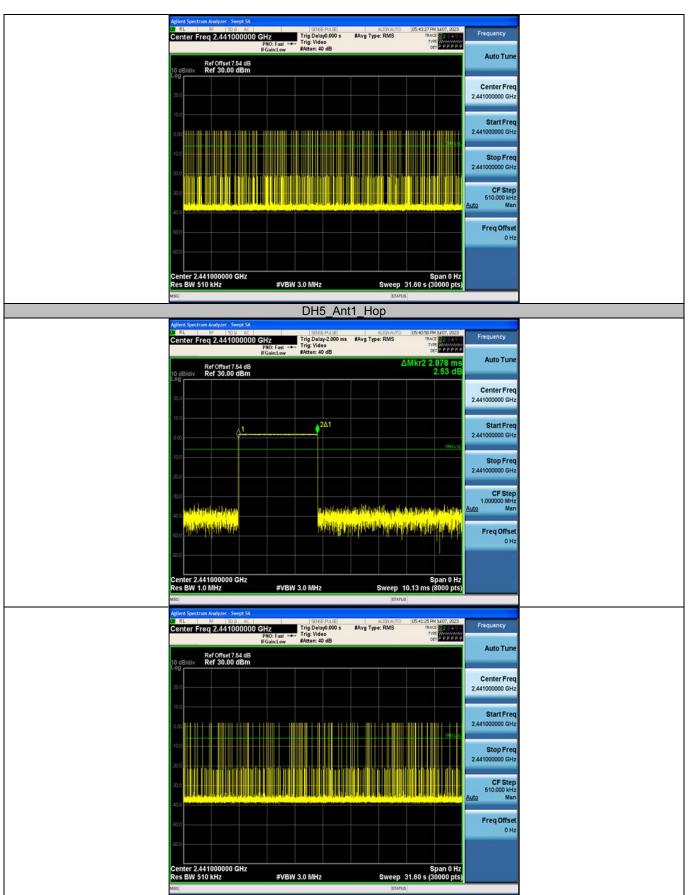
1. Period time = 0.4s * 79 = 31.6s

2. Result (Time of occupancy) = BurstWidth[ms] * Hops in 31.6s [Num]

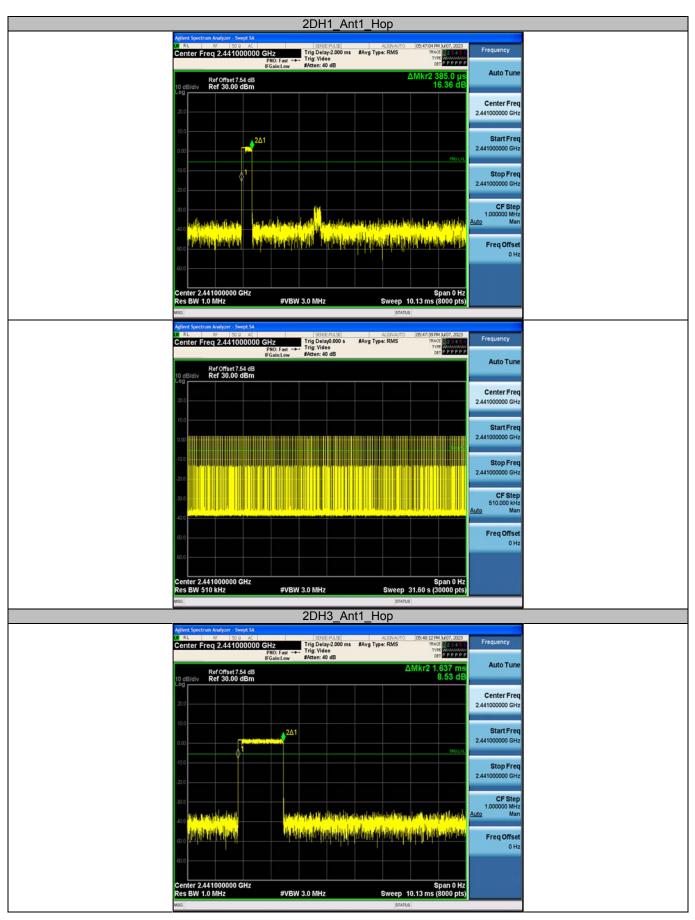


DH1_Ant1_Hop	
glient Spectrum Analyzer - Swept SA RL 95 S0.0 a.c. Strikt∈ PLLSE ALTRADITO 05:41:54 PM 1407, 2023	Frequency
PNO: Fast Ing: Video IFGain:Low #Atten: 40 dB CET PPPPP	
Ref Offset 7.54 dB Δ/Mkr2 375.0 μs 0 dB/dlv Ref 30.00 dBm 12.05 dB	Auto Tune
20.0	Center Freq 2.441000000 GHz
	Start Freq 2.441000000 GHz
	Stop Freq 2.441000000 GHz
soo _{noo} <mark>uuruu yi Abelarada ya dada aheela aheela aheela aheela ya ya ku baada aheela aheela aheela aheela aheela ah</mark>	CF Step 1.00000 MHz Auto Man
an <mark>in de la serie de serie de la serie de</mark>	Freq Offset 0 Hz
Center 2.441000000 GHz Span 0 Hz Span 0 Hz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8000 pts) SG Istatus	
Stent Spectrum Analyzer - Seg 53 RL 87 (50 a Ac) (50 a C) (50 a	Frequency
Ref Offset 7.54 dB ID dB/dly Ref 30.00 dBm	Auto Tune
	Center Freq 2.441000000 GHz
	Start Freq 2.441000000 GHz
	Stop Freq 2.441000000 GHz
	CF Step 510.000 kHz Auto Man
500	Freq Offset 0 Hz
Center 2.441000000 GHz Span 0 Hz Tes BW 510 kHz #VBW 3.0 MHz Sweep 31.60 s (30000 pts)	
DH3_Ant1_Hop	
Iglind, Spectrum, Analyzer - Swigt SA ISH 6E: PAJSE ALIGNAUTO 05-62-53 PM JU07, 2023 R.L. FF 26.00 AC ISH 6E: PAJSE ALIGNAUTO 05-62-53 PM JU07, 2023 Center Free 24.010 PM D00.00 GHz Trig Delay-2.000 ms #Avg Type: RMS IR4/2 IR4/2	Frequency
Price Fireq 2.441000000 GHz PNC: Fast →→ IFGaint.low Trigo Video #Atten: 40 dB #Avg Type: RMS trig: Video #Atten: 40 dB IPACE BES d. Sc. Trig: Video #Atten: 40 dB Ref Offset7.54 dB 00 dB/dfv CMMkr2 1.631 ms 11.75 dB	Auto Tune
	Center Freq 2.441000000 GHz
100 221	Start Freq 2.44100000 GHz
100	Stop Freq 2.441000000 GHz
	CF Step 1.00000 MHz
oo waa panalaa ahaa ahaa ahaa ahaa ahaa ahaa aha	Auto Man Freq Offset 0 Hz
Center 2.441000000 GHz Span 0 Hz Span 0 Hz Res BW 1.0 MHz #VBW 3.0 MHz Sweep 10.13 ms (8000 pts) Isig Isig Isig	

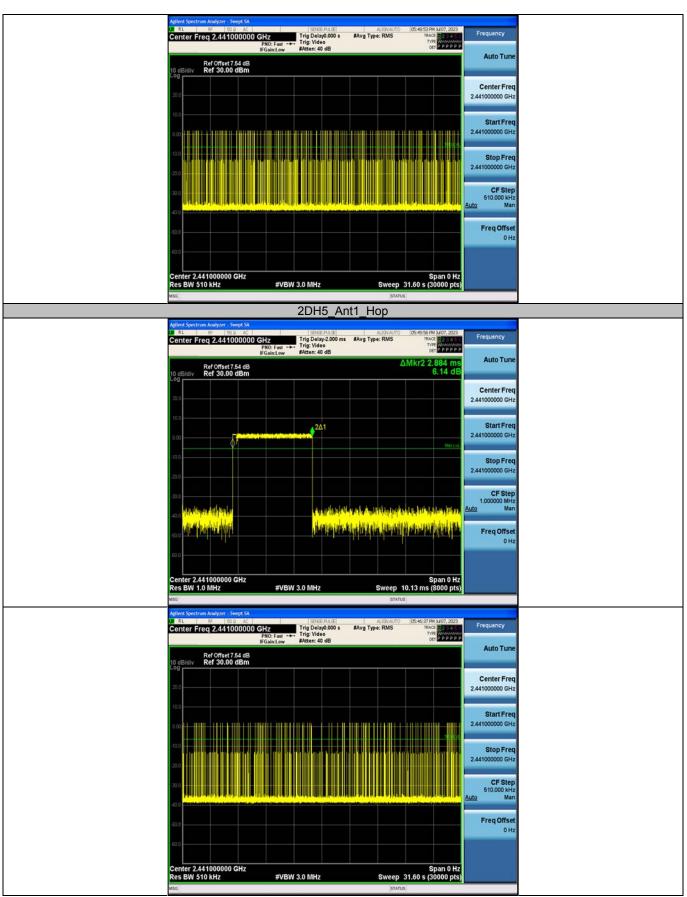














Appendix E: Number of hopping channels

Test Result

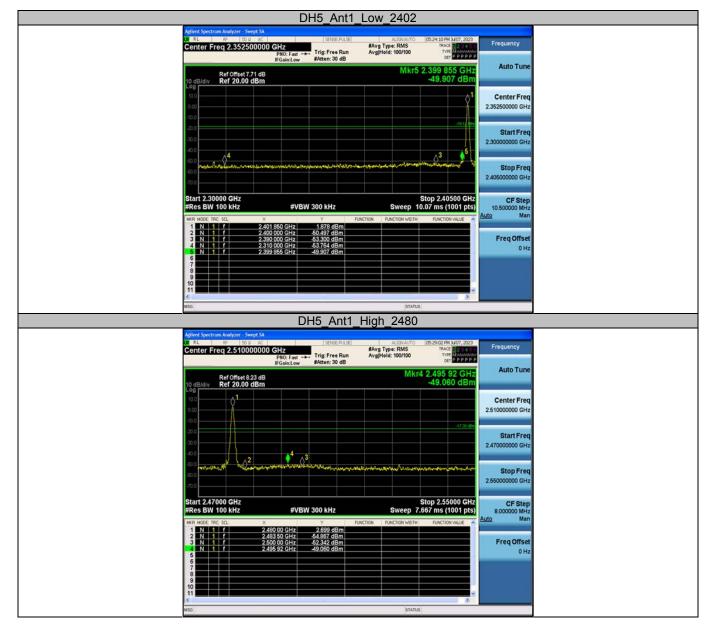
Test Mode	Antenna	Frequency [MHz]	Result [Num]	Limit [Num]	Verdict
DH5	Ant1	Нор	79	≥15	PASS
2DH5	Ant1	Нор	79	≥15	PASS



DH5_Ant1_Hop
Addlerd Spectram Analyzer September SEPERFLAG ALL/NUMO 056-023 (PE M/07, 2023) Frequency Or RC File
Ref Offset 7.48 dB Auto Tune Log Center Freq 200 2.441750000 GHz
10.0
Stop Freq 200
-30.0 -30.0 -40.0
500 FreqOffset 000
Start 2.40000 GHz Stop 2.48350 GHz #Res BW 300 kHz #VBW 300 kHz Sweep 1.133 ms (1001 pts) 950 \$\$TATUS
2DH5_Ant1_Hop
Adjent System Analyzer - Swept SA OF RL R F 059 AC 1974E FLUE AUGUATIO (054538 PM M07, 2022 Center Freq 2.441750000 GHz Trig: Free Run PGalact.ew FAtten: 40 dB
Ref Offset 7.48 dB 10 dB/dly Ref 30.00 dBm 20 0 Center Freq 2.44175000 GHz
100 2.441150000 GHz 000
-10 D -00 D -00 D
-000 CF Step -00 Man
400 Freq Offset 0 Hz
Start 2.40000 GHz Stop 2.48350 GHz #Res BW 300 kHz #VBW 300 kHz Sweep 1.133 ms (1001 pts)



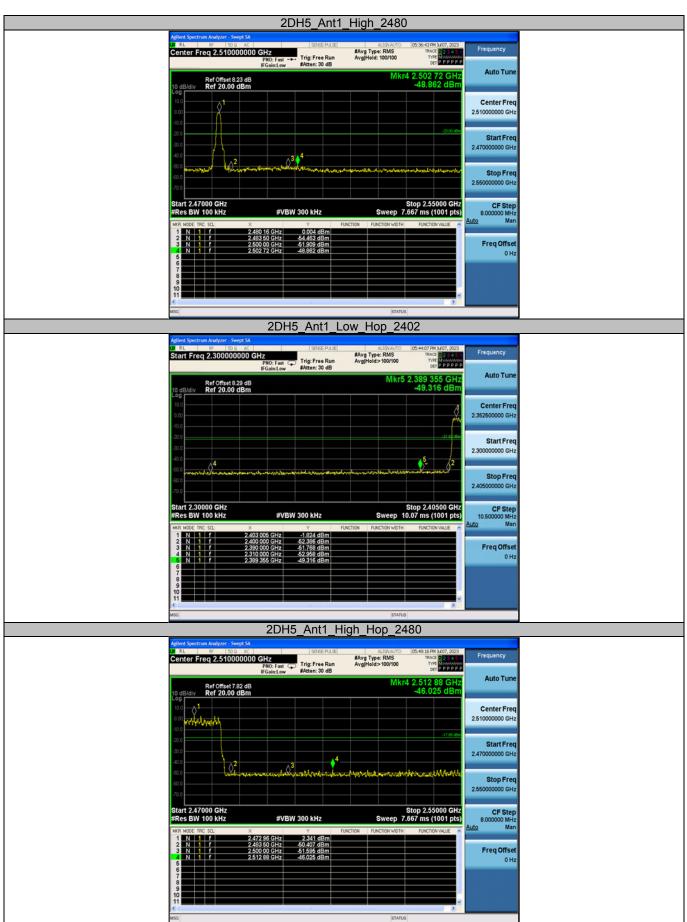
Appendix F: Band edge measurements









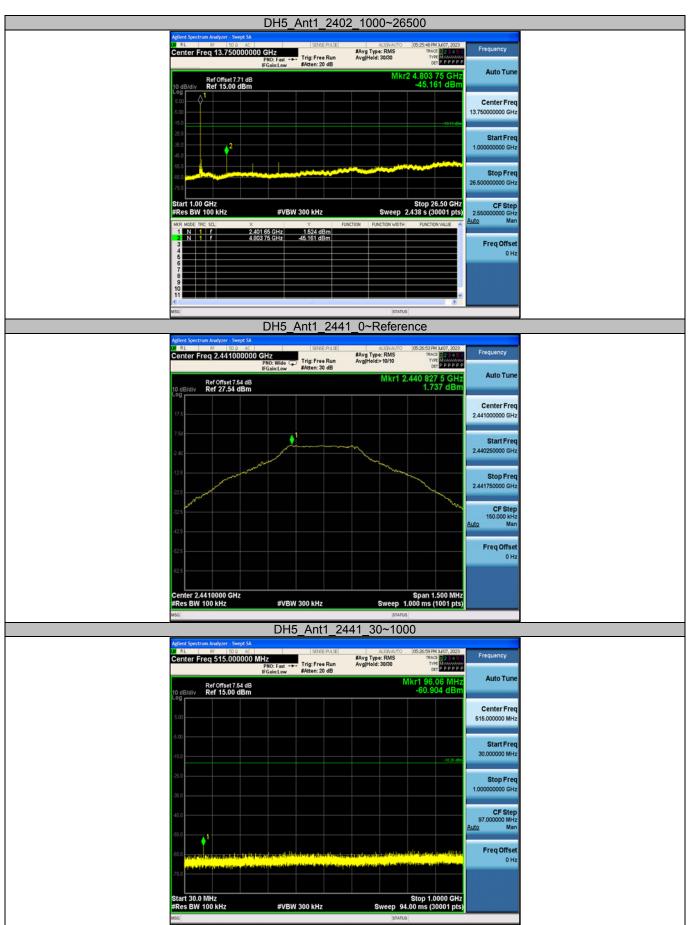




Appendix G: Conducted Spurious Emission

























Applied System Adapter. Steps 5.4 Instruction Operation Adjuster/O Adjuster/O Operation Adjuster/O A		2DH5_Ar	nt1_2480	0_1000~26	6500		
Ref Offset 8.23 dB IMK 2 4.300 TS GHz 10 dB/dt -43.009 dBm -43.009 dBm -43.009 dBm -43.009 dBm -43.009 dBm -500 -10000000 GHz -500 -10000000 GHz -500 -200000 GHz -500 -2000000 GHz -500 -2000000 GHz -500 -2000000 GHz 500 -200000 GHz 50	CT RL RF 50 Q AC	00 GHz PNO: Fast +++ Tri	g: Free Run	#Avg Type: RMS	05:38:22 PM 3/07, 2023 TRACE 2345 0 TYPE M		
500 13.750000000 GHz 500 13.750000000 GHz 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 500 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 2 510 </td <td>10 dB/div Ref 15.00 dBm</td> <td></td> <td></td> <td>Mkr</td> <td>2 4.960 15 GHz -43.009 dBm</td> <td>Auto Tune</td> <td></td>	10 dB/div Ref 15.00 dBm			Mkr	2 4.960 15 GHz -43.009 dBm	Auto Tune	
550 2 2 1.00000000 GHz 550 1.00000000 GHz 1.00000000 GHz 550 510 Freq 26.5000000 GHz 550 510 Freq 26.5000000 GHz 551 510 Freq 26.5000000 GHz 510 510 Freq 27.550 GHz 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	5.00				17.29 (69)		
600 1	-25.0 -35.0 -45.0						
#Res BW 100 kHz #VEW 300 kHz Sweep 2.438 \$ (30001 pts) MMR Note: The: SQL X Y Function Function work 1 N 1 f 2479 85 GHz 1867 dBm 3 1 f 4969 15 GHz 43009 dBm 3 4 4969 15 GHz 43009 dBm 6 6 6 6 7 8 6 6 8 8 6 6	65 0 65 0 75 0		·····				
1 N 1 f 247985 GHz 1867 dBm 2 N 1 f 4960 15 GHz 43009 dBm Freq Offset 3 N 1 f 4960 15 GHz 43009 dBm OHz 4	#Res BW 100 kHz				2.438 s (30001 pts)	2.550000000 GHz	
	1 N 1 f 2	479 85 GHz 1.	867 dBm	FUNCTION WIDTH	FUNCTION VALUE	Freq Offset	
MSG STATUS	11				×		

----End of Report----